Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/665,573	NWOKO ET AL.		
Examiner	Art Unit		
Tae H. Yoon	1714		

SEARCHED						
Class	Subclass	Date	Examiner			
523	504	3-11-06	3			
324	357					
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST Remend part case Inventor Search	2-20-06 3-14-06 3-14-06	m In			
Inventor Search	3-18-8				